



## THBT200S1

Application Specific Discretes  
A.S.D.<sup>TM</sup>

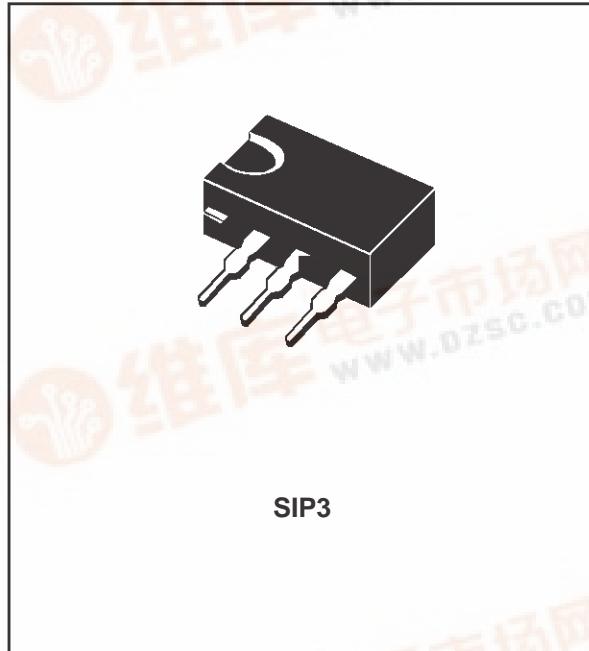
TRANSIENT VOLTAGE SUPPRESSOR  
FOR SLIC PROTECTION

### FEATURES

- DUAL BIDIRECTIONAL CROWBAR PROTECTION.
- PEAK PULSE CURRENT :
  - $I_{PP} = 35 \text{ A}$ ,  $10/1000 \mu\text{s}$ .
- HOLDING CURRENT =  $150 \text{ mA}$  min.
- BREAKDOWN VOLTAGE =  $200 \text{ V}$  min.
- BREAKOVER VOLTAGE =  $290 \text{ V}$  max.
- MONOLITHIC DEVICE.

### DESCRIPTION

This monolithic protection device has been especially designed to protect subscriber line cards. The THBT200S device is particularly suitable to protect ring generator relay against transient overvoltages.

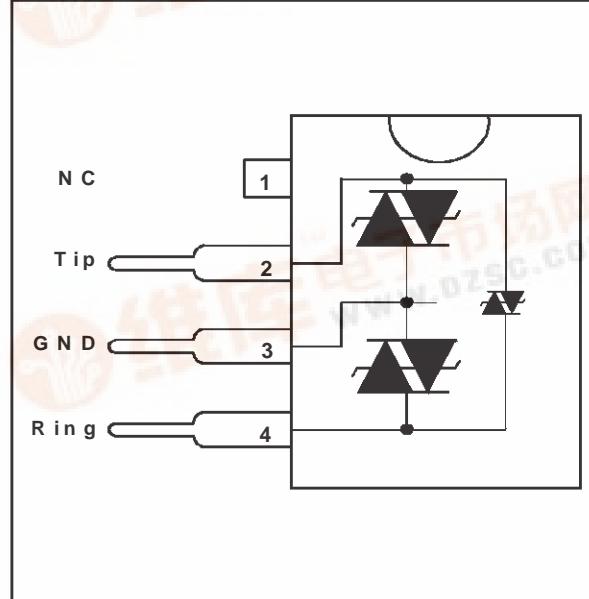


### COMPLIES WITH THE FOLLOWING STANDARDS:

CCITT K20 :	10/700 $\mu\text{s}$	1kV
	5/310 $\mu\text{s}$	25A
VDE 0433 :	10/700 $\mu\text{s}$	2kV
	5/310 $\mu\text{s}$	45A (*)
VDE 0878 :	1.2/50 $\mu\text{s}$	1.5kV
	1/20 $\mu\text{s}$	40A
FCC part 68 :	2/10 $\mu\text{s}$	2.5kV
	2/20 $\mu\text{s}$	80A (*)
BELLCORE TR-NWT-001089 :	2/10 $\mu\text{s}$	2.5kV
	2/10 $\mu\text{s}$	80A
	10/1000 $\mu\text{s}$	1kV
	10/1000 $\mu\text{s}$	35A (*)

(\*) with series resistors or PTC.

### SCHEMATIC DIAGRAM



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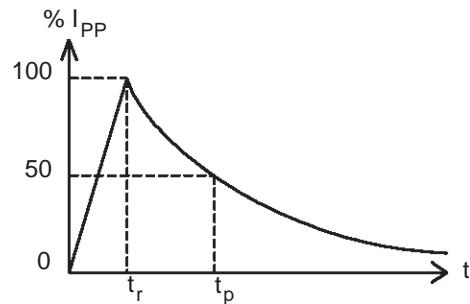
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### ABSOLUTE MAXIMUM RATINGS ( $T_{amb} = 25^{\circ}\text{C}$ )

Symbol	Parameter		Value	Unit
$I_{PP}$	Peak pulse current (see note 1)	10/1000 $\mu\text{s}$ 8/20 $\mu\text{s}$ 2/10 $\mu\text{s}$	35 70 80	A
$I_{TSM}$	Non repetitive surge peak on-state current	$t_p = 20\text{ms}$	20	A
$T_{stg}$ $T_j$	Storage and operating junction temperature range Maximum junction temperature		- 40 to + 150 + 150	$^{\circ}\text{C}$
$T_L$	Maximum lead temperature for soldering during 10s		230	$^{\circ}\text{C}$

Note 1 : Pulse waveform :

$$\begin{array}{lll} 10/1000\mu\text{s} & t_r=10\mu\text{s} & t_p=1000\mu\text{s} \\ 5/310\mu\text{s} & t_r=5\mu\text{s} & t_p=310\mu\text{s} \\ 2/10\mu\text{s} & t_r=2\mu\text{s} & t_p=10\mu\text{s} \end{array}$$

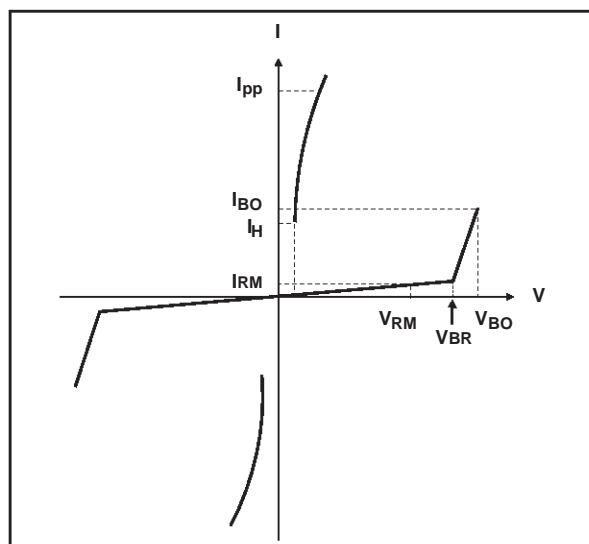


### THERMAL RESISTANCE

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	80	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS ( $T_{amb}=25^{\circ}\text{C}$ )

Symbol	Parameter
$V_{RM}$	Stand-off voltage
$I_{RM}$	Leakage current at $V_{RM}$
$V_{BR}$	Continuous reverse voltage
$V_{BO}$	Breakover voltage
$I_H$	Holding current
$I_{BO}$	Breakover current
$I_{PP}$	Peak pulse current
C	Capacitance



## 1 - PARAMETERS RELATED TO ONE TRISIL. (Between TIP and GND or RING and GND)

$I_{RM}$ @ $V_{RM}$ max.		$V_{BR}$ @ $I_R$ min.		$V_{BO}$ @ $I_{BO}$ max.      min.      max. note 1			$I_H$ min. note 2	C max. note 3
$\mu\text{A}$	V	V	mA	V	mA	mA	mA	pF
10	180	200	1	290	150	800	150	200

Note 1 : See reference test circuit 1 for  $I_H$ ,  $I_{BO}$  and  $V_{BO}$  parameters.

Note 2 : See test circuit 2.

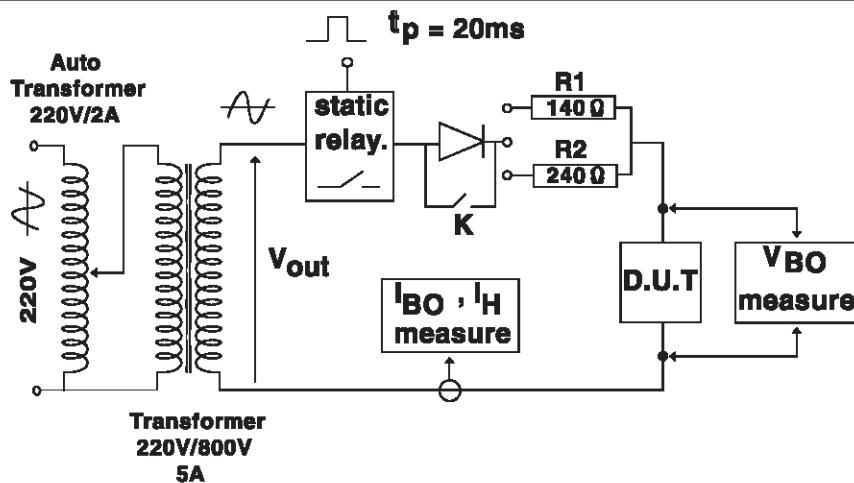
Note 3 :  $V_R = 1\text{V}$ ,  $F = 1\text{MHz}$ .

2 - PARAMETERS RELATED TO  
TIP and RING TRISIL.

$I_{RM}$ @ $V_{RM}$ max.		C max.
$\mu\text{A}$	V	pF
10	180	200

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### REFERENCE TEST CIRCUIT 1 FOR $I_{BO}$ and $V_{BO}$ parameters :



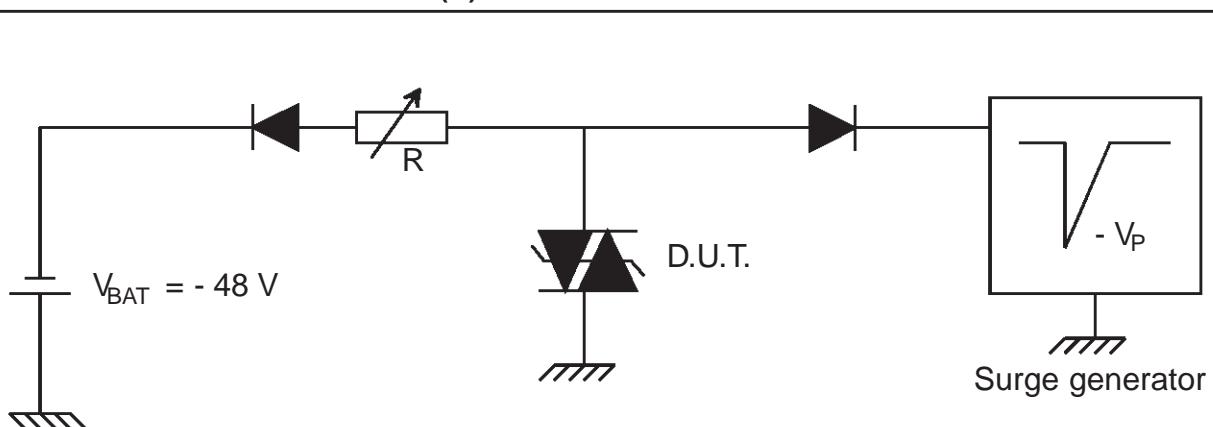
#### TEST PROCEDURE :

- Pulse Test duration ( $t_p = 20\text{ms}$ ):  
 - For Bidirectional devices = Switch K is closed  
 - For Unidirectional devices = Switch K is open.

#### $V_{out}$ Selection

- Device with  $V_{BO} < 200$  Volt
  - $V_{out} = 250 \text{ V}_{\text{RMS}}$ ,  $R_1 = 140 \Omega$ .
- Device with  $V_{BO} \geq 200$  Volt
  - $V_{out} = 480 \text{ V}_{\text{RMS}}$ ,  $R_2 = 240 \Omega$ .

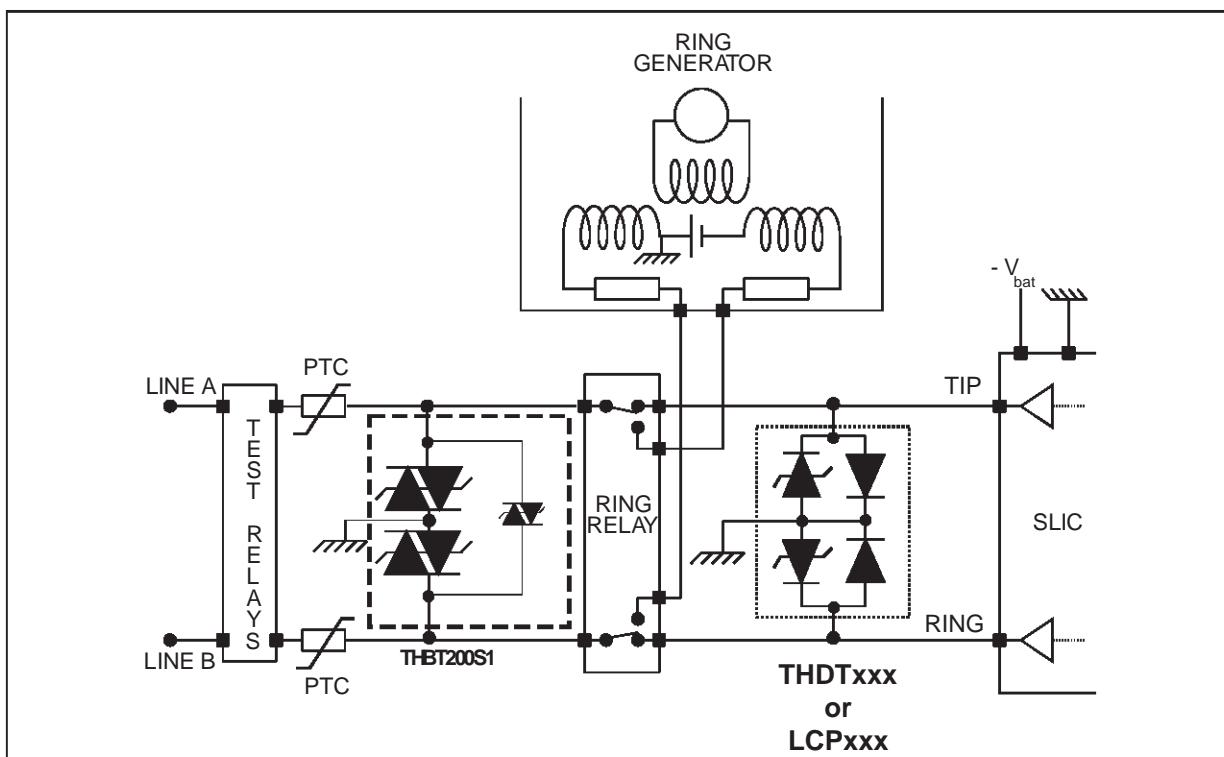
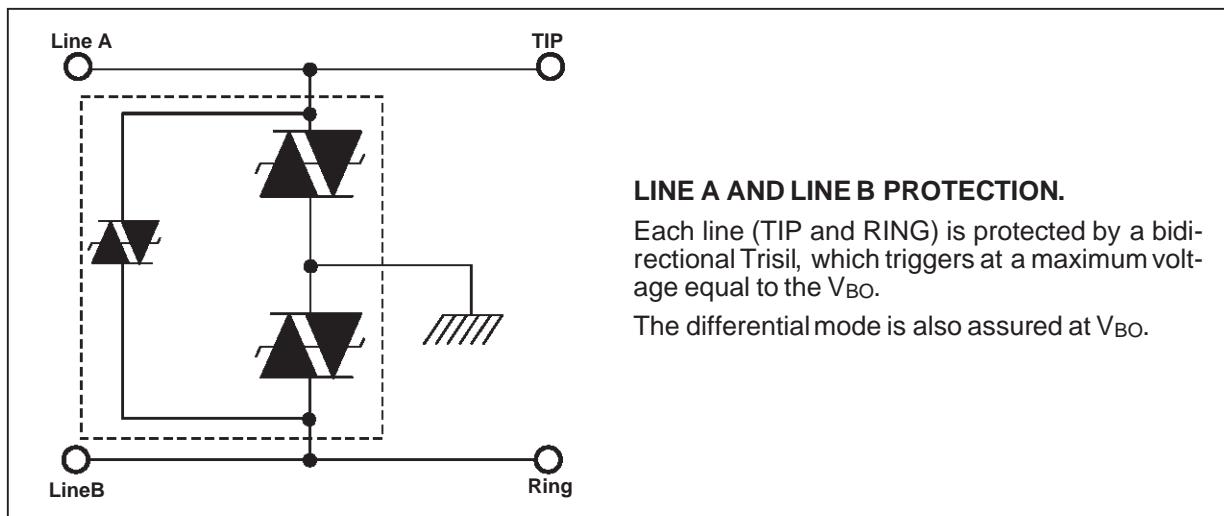
### FUNCTIONAL HOLDING CURRENT ( $I_H$ ) TEST CIRCUIT 2.



This is a GO-NOGO Test which allows to confirm the holding current ( $I_H$ ) level in a functional test circuit.

#### TEST PROCEDURE :

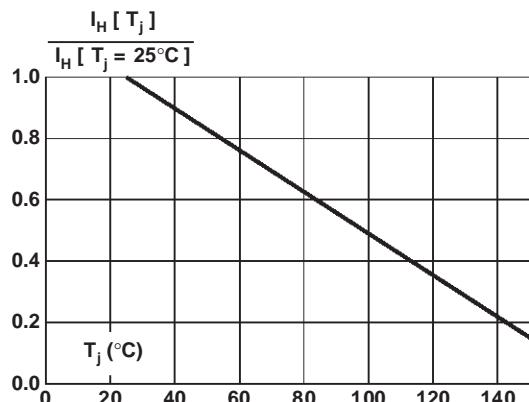
- 1) Adjust the current level at the  $I_H$  value by short circuiting the AK of the D.U.T.
- 2) Fire the D.U.T with a surge Current :  $I_{pp} = 10\text{A}$ ,  $10/1000\mu\text{s}$ .
- 3) The D.U.T will come back off-state within 50 ms max.

**APPLICATION CIRCUIT****Typical line card protection concept****FUNCTIONAL DESCRIPTION**

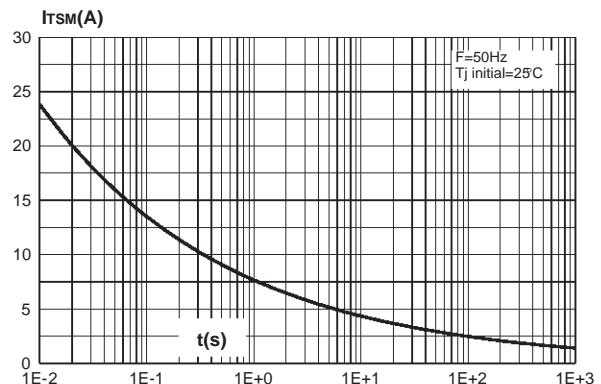
## THBT200S1

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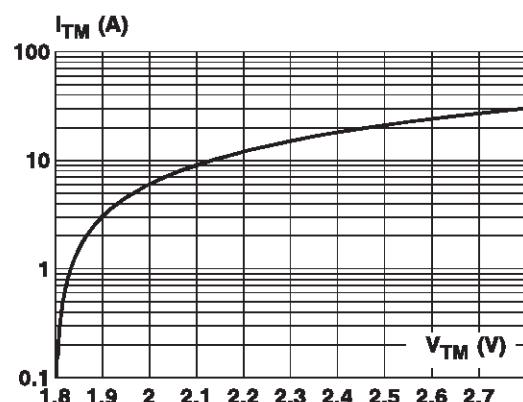
**Fig. 1** : Relative variation of holding current versus junction temperature.



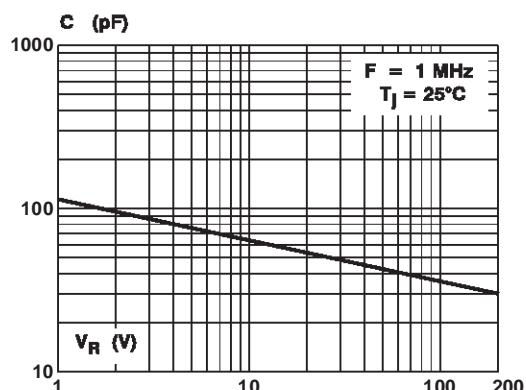
**Fig. 2** : Surge peak current versus overload duration.



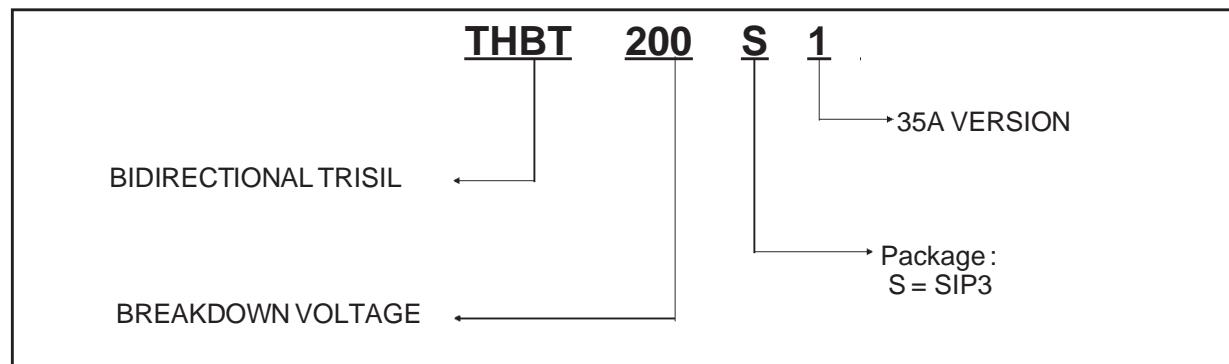
**Fig. 3** : Peak on state voltage versus peak on state current (typical values).



**Fig. 4** : Capacitance versus reverse applied voltage (typical values).

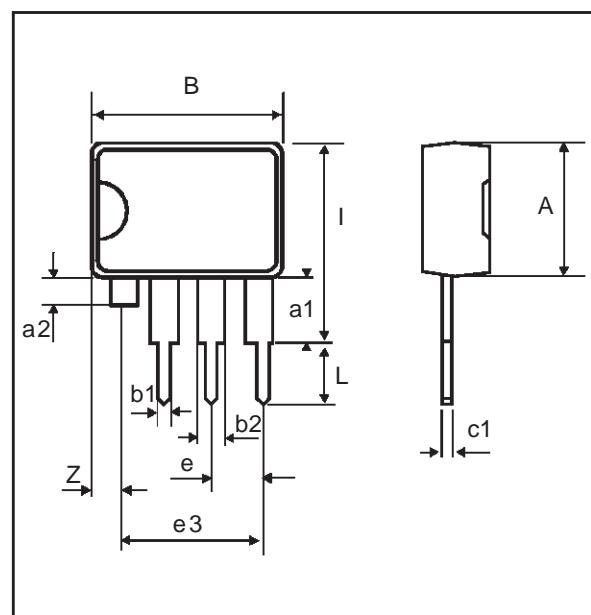


## ORDER CODE



## MARKING :

Package	Types	Marking
SIP3	THBT200S1	TBT200S1

PACKAGE MECHANICAL DATA  
SIP3 Plastic

REF.	DIMENSIONS					
	Millimetres			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A				7.10		0.280
a1	2.80			0.110		
a2	1.50			0.059		0.075
B				10.15		0.400
b1		0.50			0.020	
b2	1.35			1.75	0.053	0.069
c1	0.38			0.50	0.015	0.020
e		2.54			0.100	
e3		7.62			0.200	
I				10.50		0.413
L		3.30			0.130	
Z				1.50		0.059

**Packaging:** Products supplied in antistatic tubes.**Weight :** 0.55g

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